



VNQ5050K-E

Quad channel high side driver for automotive applications

Features

Max supply voltage	V_{CC}	41 V
Operating voltage range	V_{CC}	4.5 to 36 V
Max on-state resistance (per ch.)	R_{ON}	50 m Ω
Current limitation (typ)	I_{LIMH}	19 A
Off-state supply current	I_S	2 μ A ⁽¹⁾

1. Typical value with all loads connected

■ General features

- Inrush current active management by power limitation
- Very low standby current
- 3.0 V CMOS compatible input
- Optimized electromagnetic emission
- Very low electromagnetic susceptibility
- In compliance with the 2002/95/EC European directive

■ Diagnostic functions

- Open drain status output
- On-state open load detection
- Off-state open load detection
- Thermal shutdown indication

■ Protection

- Undervoltage shutdown
- Overvoltage clamp
- Load current limitation
- Self limiting of fast thermal transients
- Protection against loss of ground and loss of V_{CC}
- Thermal shutdown
- Reverse battery protection (see [Application schematic on page 19](#))
- Electrostatic discharge protection



PowerSSO-24

Applications

- All types of resistive, inductive and capacitive loads

Description

The VNQ5050K-E is a monolithic device made using STMicroelectronics VIPower M0-5 technology. It is intended for driving resistive or inductive loads with one side connected to ground. Active V_{CC} pin voltage clamp protects the device against low energy spikes (see ISO7637 transient compatibility table).

The device detects open load condition both in on and off-state, when STAT_DIS is left open or driven low. Output shorted to V_{CC} is detected in the off-state.

When STAT_DIS is driven high, the STATUS pin is in a high impedance condition.

Output current limitation protects the device in overload condition. In case of long overload duration, the device limits the dissipated power to a safe level up to thermal shutdown intervention. Thermal shutdown with automatic restart allows the device to recover normal operation as soon as the fault condition disappears.

Table 1. Device summary

Package	Order code	
	Tube	Tape and reel
PowerSSO-24	VNQ5050K-E	VNQ5050KTR-E

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1 Block diagram and pin configuration

Figure 1. Block diagram

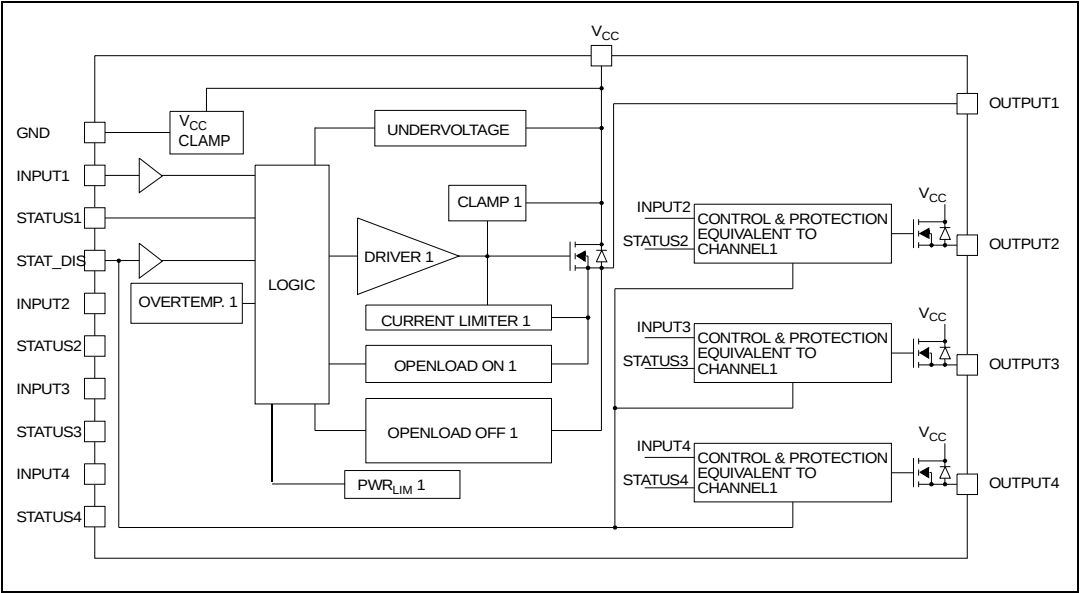


Table 2. Pin functions

Name	Function
V _{CC}	Battery connection
OUTPUTn	Power output
GND	Ground connection. Must be reverse battery protected by an external diode/resistor network
INPUTn	Voltage controlled input pin with hysteresis, CMOS compatible. Controls output switch state
STATUSn	Open drain digital diagnostic pin
STAT_DIS	Active high CMOS compatible pin, to disable the STATUS pin

Figure 2. Configuration diagram (top view)

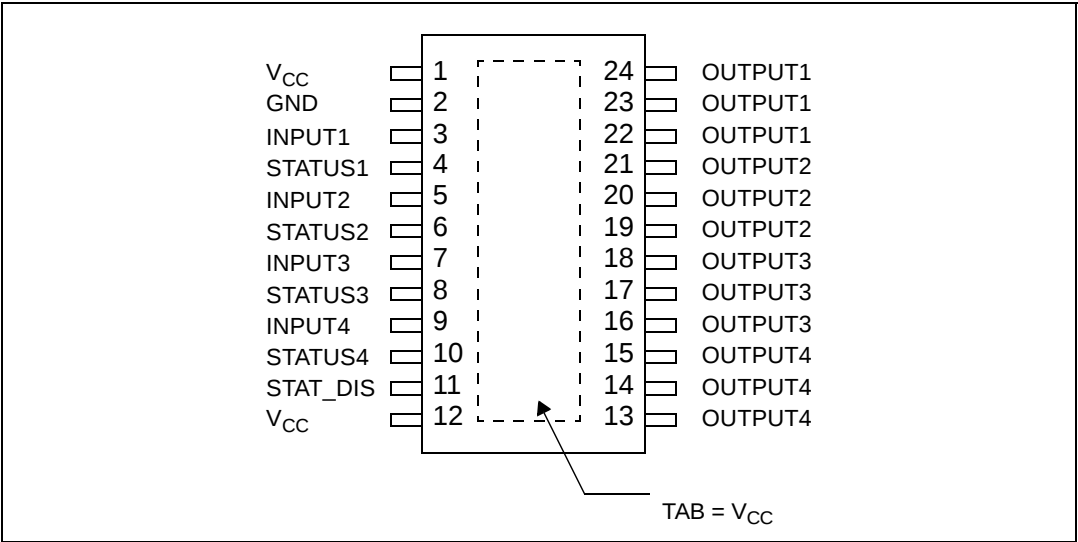


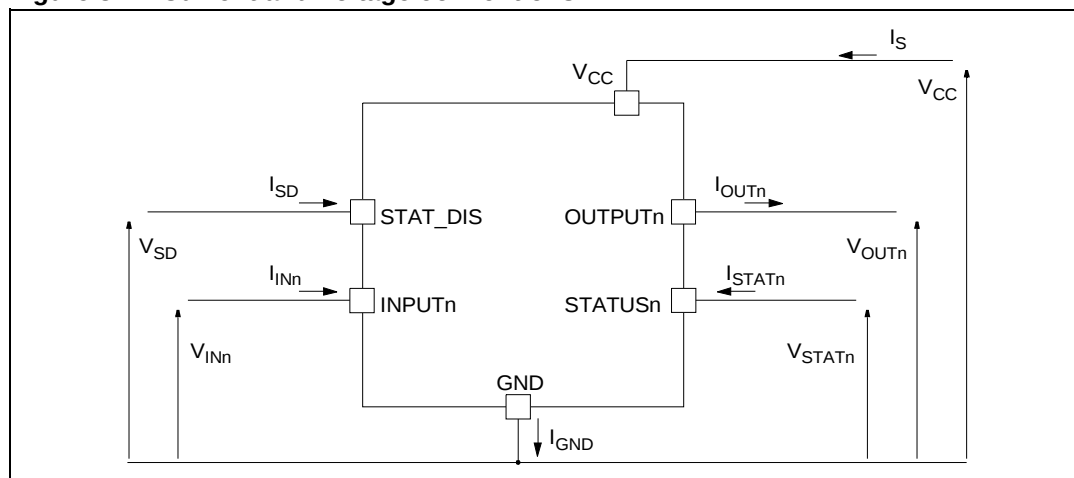
Table 3. Suggested connections for unused and not connected pins

Connection/pin	Status	N.C.	Output	Input	STAT_DIS
Floating	X	X	X	X	X
To ground	N.R. ⁽¹⁾	X	N.R.	Through 10 KΩ resistor	Through 10 KΩ resistor

1. Not recommended

2 Electrical specifications

Figure 3. Current and voltage conventions



Note: $V_{Fn} = V_{OUTn} - V_{CC}$ during reverse battery condition

2.1 Absolute maximum ratings

Stressing the device above the ratings listed in the “Absolute maximum ratings” tables may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to the conditions in this section for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CC}	DC supply voltage	41	V
$-V_{CC}$	Reverse DC supply voltage	0.3	V
$-I_{GND}$	DC reverse ground pin current	200	mA
I_{OUT}	DC output current	Internally limited	A
$-I_{OUT}$	Reverse DC output current	15	A
I_{IN}	DC input current	+10/-1	mA
I_{STAT}	DC status current	+10/-1	mA
I_{STAT_DIS}	DC status disable current	+10 / -1	mA
E_{MAX}	Maximum switching energy (single pulse) ($L=3\text{ mH}$; $R_L=0\Omega$; $V_{bat}=13.5\text{V}$; $T_{jstart}=150^\circ\text{C}$; $I_{OUT} = I_{limL}(\text{typ.})$)	104	mJ

Table 4. Absolute maximum ratings (continued)

Symbol	Parameter	Value	Unit
V _{ESD}	Electrostatic discharge (human body model: R=1.5KΩ; C=100pF)		
	– Input	4000	V
	– Status	4000	V
	– STAT_DIS	4000	V
	– Output	5000	V
	– V _{CC}	5000	V
V _{ESD}	Charge device model (CDM-AEC-Q100-011)	750	V
T _j	Junction operating temperature	-40 to 150	°C
T _{stg}	Storage temperature	- 55 to 150	°C

2.2 Thermal data

Table 5. Thermal data

Symbol	Parameter	Max value	Unit
R _{thj-case}	Thermal resistance junction-case (With one channel ON)	2.8	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	See Figure 32 .	°C/W

2.3 Electrical characteristics

Values specified in this section are for $8\text{ V} < V_{CC} < 36\text{ V}$, $-40\text{ }^{\circ}\text{C} < T_j < 150\text{ }^{\circ}\text{C}$, unless otherwise stated.

Table 6. Power section

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{CC}	Operating supply voltage		4.5	13	36	V
V_{USD}	Undervoltage shutdown			3.5	4.5	V
$V_{USDhyst}$	Undervoltage shutdown hysteresis			0.5		V
R_{ON}	On-state resistance ⁽¹⁾	$I_{OUT}=2\text{A}$; $T_j=25^{\circ}\text{C}$ $I_{OUT}=2\text{A}$; $T_j=150^{\circ}\text{C}$ $I_{OUT}=2\text{A}$; $V_{CC}=5\text{V}$; $T_j=25^{\circ}\text{C}$			50 100 65	mΩ mΩ mΩ
V_{clamp}	Clamp Voltage	$I_S=20\text{ mA}$	41	46	52	V
I_S	Supply current	Off-state; $V_{CC}=13\text{V}$; $V_{IN}=V_{OUT}=0\text{V}$; $T_j=25^{\circ}\text{C}$ On-state; $V_{IN}=5\text{V}$; $V_{CC}=13\text{V}$; $I_{OUT}=0\text{A}$		2 ⁽²⁾ 8	5 ⁽²⁾ 14	μA mA
$I_{L(off1)}$	Off-state output current ⁽¹⁾	$V_{IN}=V_{OUT}=0\text{V}$; $V_{CC}=13\text{V}$; $T_j=25^{\circ}\text{C}$ $V_{IN}=V_{OUT}=0\text{V}$; $V_{CC}=13\text{V}$; $T_j=125^{\circ}\text{C}$	0 0	0.01	3 5	μA μA
$I_{L(off2)}$	Off-state output current ⁽¹⁾	$V_{IN}=0\text{V}$; $V_{OUT}=4\text{V}$	-75		0	μA
V_F	Output - V_{CC} diode voltage ⁽¹⁾	$-I_{OUT}=2\text{A}$; $T_j=150^{\circ}\text{C}$			0.7	V

1. For each channel.

2. PowerMOS leakage included

Table 7. Switching ($V_{CC}=13\text{V}$; $T_j=25^{\circ}\text{C}$)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$R_L=6.5\Omega$ (see Figure 6)	-	15	-	μs
$t_{d(off)}$	Turn-off delay time	$R_L=6.5\Omega$ (see Figure 6)	-	40	-	μs
$dV_{OUT}/dt_{(on)}$	Turn-on voltage slope	$R_L=6.5\Omega$ (See Figure 16)	-		-	V/μs
$dV_{OUT}/dt_{(off)}$	Turn-off voltage slope	$R_L=6.5\Omega$ (See Figure 18)	-		-	V/μs
W_{ON}	Switching energy losses during t_{won}	$R_L=6.5\Omega$ (see Figure 6)	-	0.19	-	mJ
W_{OFF}	Switching energy losses during t_{woff}	$R_L=6.5\Omega$ (see Figure 6)	-	0.27	-	mJ

Table 8. Status pin ($V_{SD}=0$)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{STAT}	Status low output voltage	$I_{STAT}=1.6\text{ mA}$, $V_{SD}=0\text{V}$			0.5	V
I_{LSTAT}	Status leakage current	Normal operation or $V_{SD}=5\text{V}$, $V_{STAT}=5\text{V}$			10	μA
C_{STAT}	Status pin input capacitance	Normal operation or $V_{SD}=5\text{V}$, $V_{STAT}=5\text{V}$			100	pF
V_{SCL}	Status clamp voltage	$I_{STAT}=1\text{mA}$ $I_{STAT}=-1\text{mA}$	5.5	-0.7	7	V V

Table 9. Protections

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{limH}	DC short circuit current	$V_{CC}=13\text{V}$ $5\text{V}<V_{CC}<36\text{V}$	13.5	19	26.5 26.5	A A
I_{limL}	Short circuit current during thermal cycling	$V_{CC}=13\text{V}$ $T_R<T_J<T_{TSD}$		7		A
T_{TSD}	Shutdown temperature		150	175	200	$^{\circ}\text{C}$
T_R	Reset temperature		$T_{RS}+1$	$T_{RS}+5$		$^{\circ}\text{C}$
T_{RS}	Thermal reset of STATUS		135			$^{\circ}\text{C}$
T_{HYST}	Thermal hysteresis ($T_{TSD}-T_R$)			7		$^{\circ}\text{C}$
t_{SDL}	Status delay in overload conditions	$T_J>T_{TSD}$ (See Figure 4)			20	μs
V_{DEMAG}	Turn-off output voltage clamp	$I_{OUT}=2\text{A}$; $V_{IN}=0$; $L=6\text{mH}$	$V_{CC}-41$	$V_{CC}-46$	$V_{CC}-52$	V
V_{ON}	Output voltage drop limitation	$I_{OUT}=0.1\text{A}$ (see Figure 5) $T_J=-40^{\circ}\text{C}\dots+150^{\circ}\text{C}$		25		mV

Note: To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper software strategy. If the device is subjected to abnormal conditions, this software must limit the duration and number of activation cycles

Table 10. Open-load detection

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{OL}	Open-load on-state detection threshold	$V_{IN}=5\text{V}$, $8\text{V}<V_{CC}<18\text{V}$ (See Figure 22.)	10		70	mA
$t_{DOL(on)}$	Open-load on-state detection delay	$I_{OUT}=0\text{A}$, $V_{CC}=13\text{V}$ (See Figure 4.)			200	μs

Table 10. Open-load detection (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t_{POL}	Delay between input falling edge and status rising edge in open-load condition	$I_{OUT} = 0A$ (See Figure 4.)	200	500	1000	μs
V_{OL}	Open-load off-state voltage detection threshold	$V_{IN} = 0V$, $8V < V_{CC} < 16V$ (See Figure 23.)	2		4	V
t_{DSTKON}	Output short circuit to V_{CC} detection delay at turn-off	(See Figure 4.)	180		t_{POL}	μs

Table 11. Logic input

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{IL}	Input low level				0.9	V
I_{IL}	Low level input current	$V_{IN} = 0.9V$	1			μA
V_{IH}	Input high level		2.1			V
I_{IH}	High level input current	$V_{IN} = 2.1V$			10	μA
$V_{I(hyst)}$	Input hysteresis voltage		0.25			V
V_{ICL}	Input clamp voltage	$I_{IN} = 1mA$ $I_{IN} = -1mA$	5.5	-0.7	7	V V
V_{SDL}	STAT_DIS low level voltage				0.9	V
I_{SDL}	Low level STAT_DIS current	$V_{SD} = 0.9V$	1			μA
V_{SDH}	STAT_DIS high level voltage		2.1			V
I_{SDH}	High level STAT_DIS current	$V_{SD} = 2.1V$			10	μA
$V_{SD(hyst)}$	STAT_DIS hysteresis voltage		0.25			V
V_{SDCL}	STAT_DIS clamp voltage	$I_{SD} = 1mA$ $I_{SD} = -1mA$	5.5	-0.7	7	V V

Figure 4. Status timings

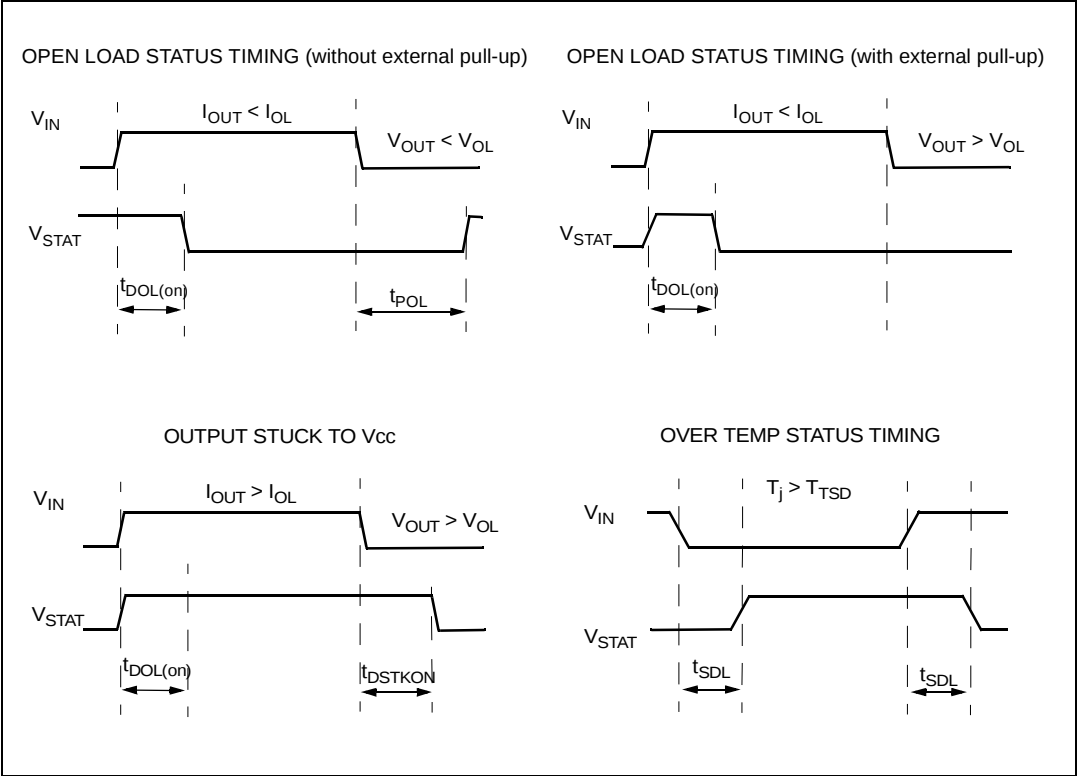


Figure 5. Output voltage drop limitation

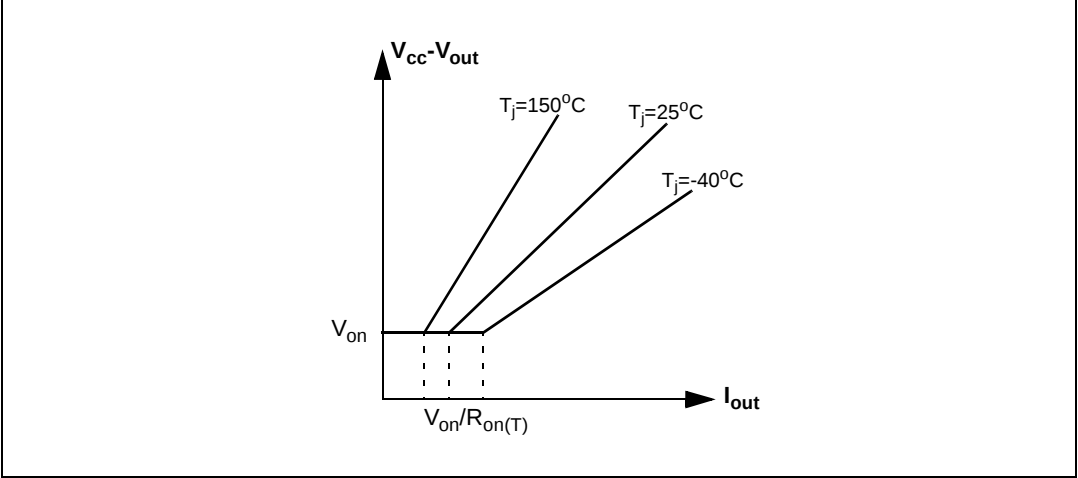


Table 12. Truth table

Conditions	Input	Output	Status ($V_{SD}=0V$) ⁽¹⁾
Normal operation	L	L	H
	H	H	H
Current limitation	L	L	H
	H	X	H

Table 12. Truth table (continued)

Conditions	Input	Output	Status ($V_{SD}=0V$) ⁽¹⁾
Over temperature	L	L	H
	H	L	L
Undervoltage	L	L	X
	H	L	X
Output voltage > V_{OL}	L	H	L ⁽²⁾
	H	H	H
Output current < I_{OL}	L	L	H ⁽³⁾
	H	H	L

1. If the V_{SD} is high, the STATUS pin is in a high impedance.
2. The STATUS pin is low with a delay equal to t_{DSTKON} after INPUT falling edge.
3. The STATUS pin becomes high with a delay equal to t_{POL} after INPUT falling edge.

Figure 6. Switching characteristics

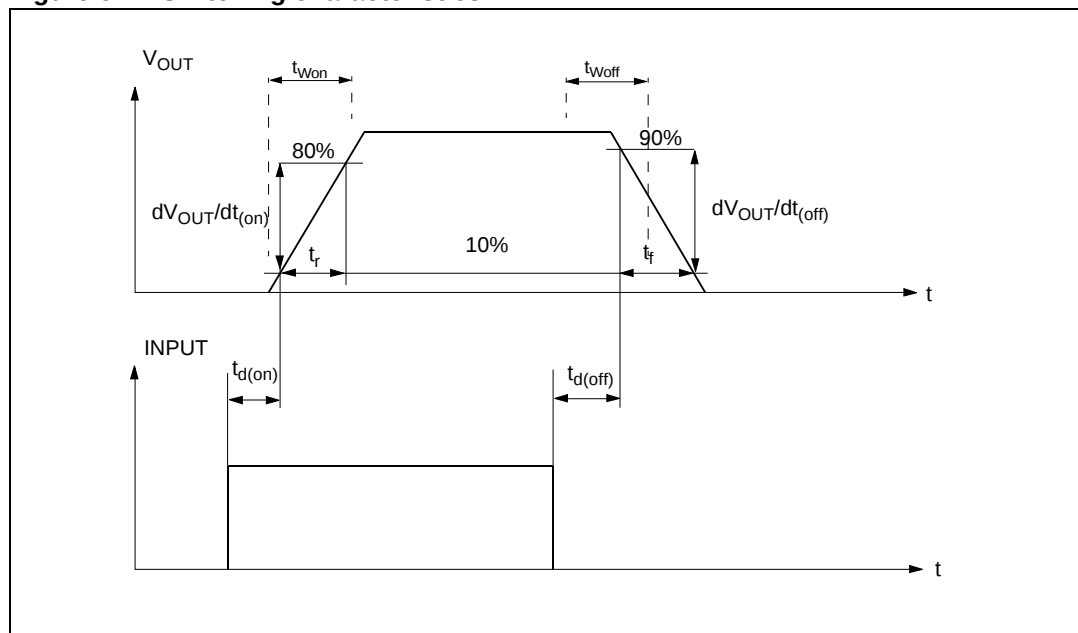


Table 13. Electrical transient requirements (part 1/3)

ISO 7637-2: 2004(E) test Pulse	Test levels ⁽¹⁾		Number of pulses or test times	Burst cycle/pulse repetition time		Delays and impedance
	III	IV				
1	-75 V	-100 V	5000 pulses	0.5 s	5 s	2 ms, 10 Ω
2a	+37 V	+50 V	5000 pulses	0.2 s	5 s	50 μ s, 2 Ω
3a	-100 V	-150 V	1h	90 ms	100 ms	0.1 μ s, 50 Ω
3b	+75 V	+100 V	1h	90 ms	100 ms	0.1 μ s, 50 Ω

Table 13. Electrical transient requirements (part 1/3) (continued)

ISO 7637-2: 2004(E) test Pulse	Test levels ⁽¹⁾		Number of pulses or test times	Burst cycle/pulse repetition time	Delays and impedance
	III	IV			
4	-6 V	-7 V	1 pulse		100 ms, 0.01 Ω
5b ⁽²⁾	+65 V	+87 V	1 pulse		400 ms, 2 Ω

Table 14. Electrical transient requirements (part 2/3)

ISO 7637-2: 2004(E) test pulse	Test level results ⁽¹⁾	
	III	IV
1	C	C
2a	C	C
3a	C	C
3b	C	C
4	C	C
5b ⁽²⁾	C	C

1. The above test levels must be considered referred to $V_{CC} = 13.5V$ except for pulse 5b
2. Valid in case of external load dump clamp: 40V maximum referred to ground.

Table 15. Electrical transient requirements (part 3/3)

Class	Contents
C	All functions of the device are performed as designed after exposure to disturbance.
E	One or more functions of the device are not performed as designed after exposure to disturbance and cannot be returned to proper operation without replacing the device.

2.4 Electrical characteristics curves

Figure 7. Off-state output current

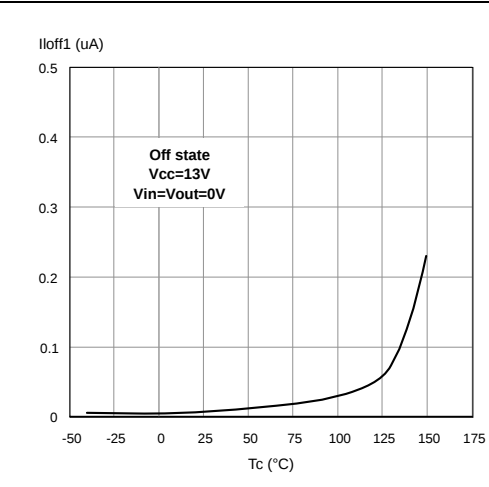


Figure 8. High level input current

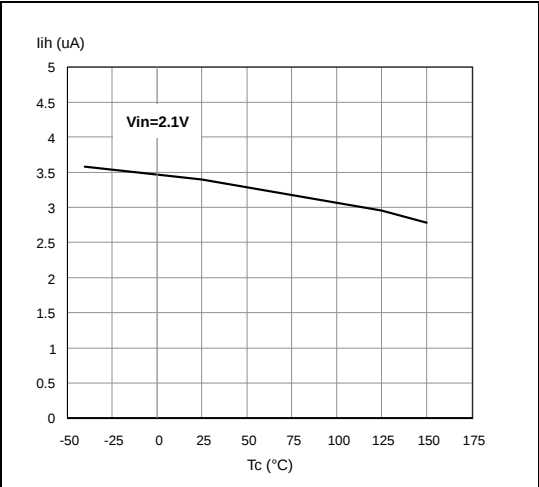


Figure 9. Input clamp voltage

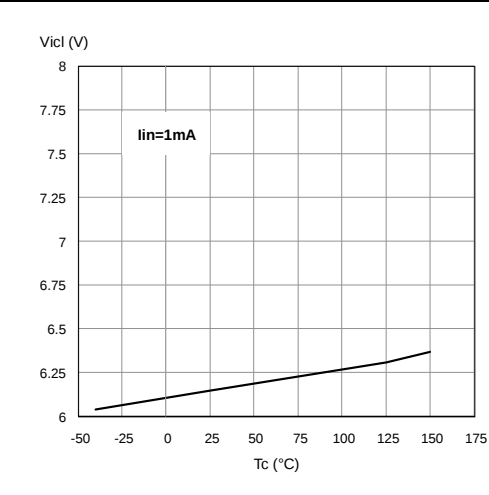


Figure 10. Input low level

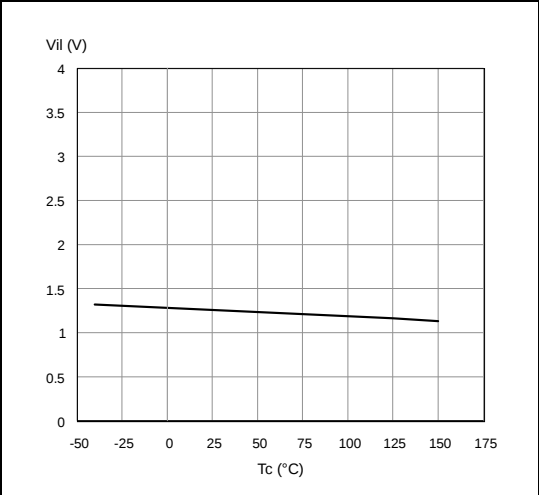


Figure 11. Input high level

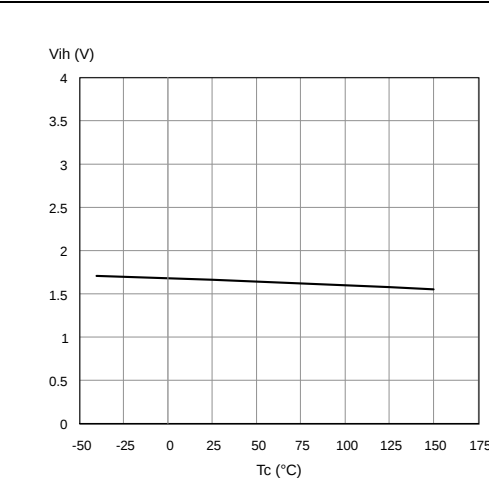


Figure 12. Input hysteresis voltage

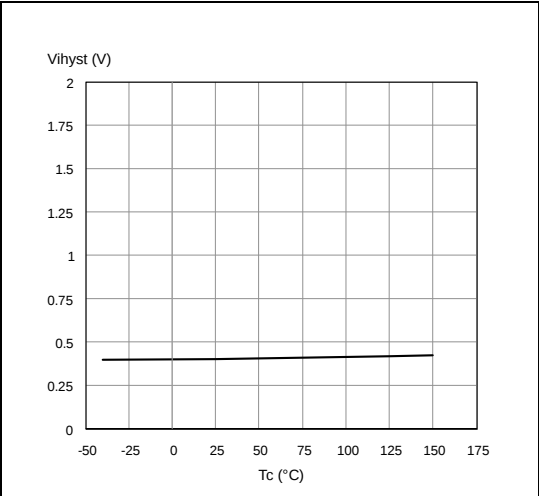


Figure 13. On-state resistance vs T_{case}

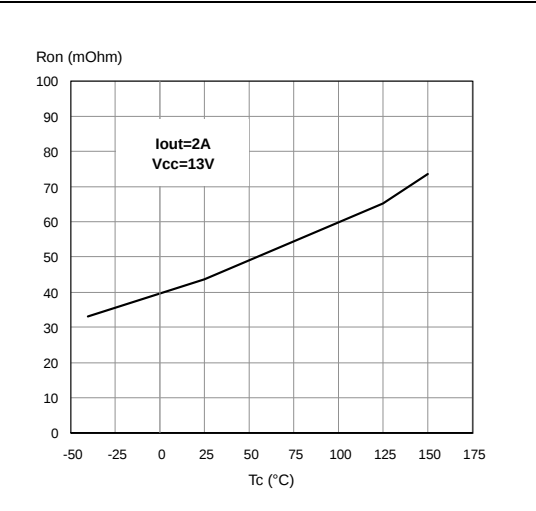


Figure 14. On-state resistance vs V_{CC}

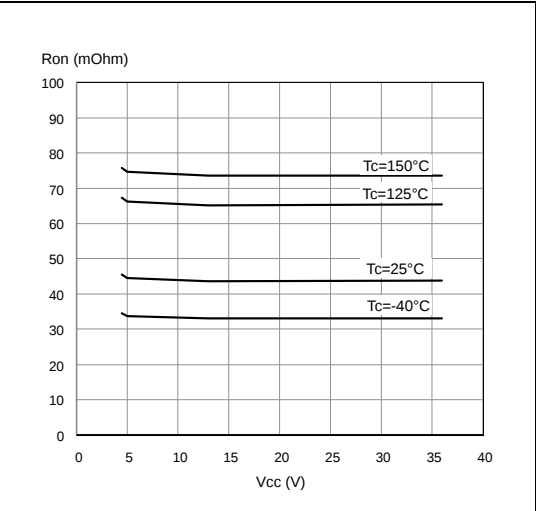


Figure 15. Undervoltage shutdown

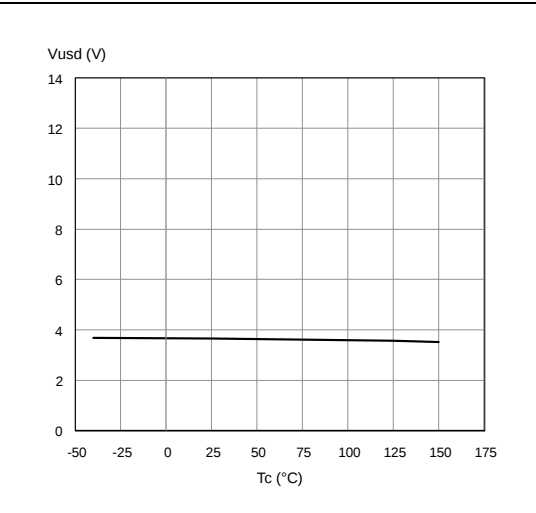


Figure 16. Turn-on voltage slope

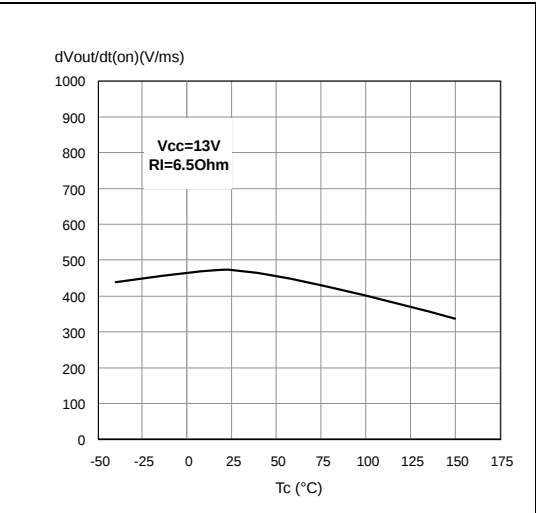


Figure 17. I_{LIMH} vs T_{case}

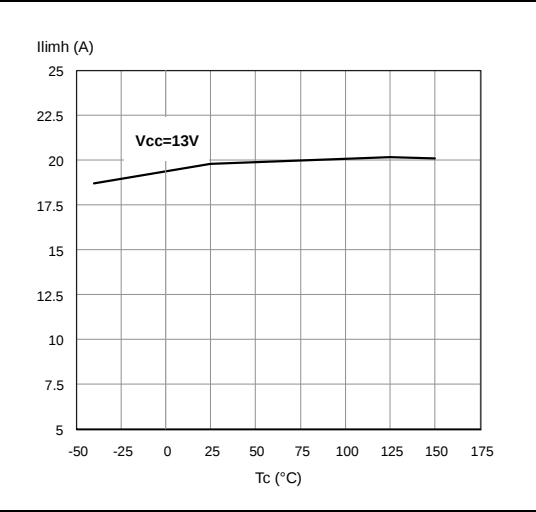


Figure 18. Turn-off voltage slope

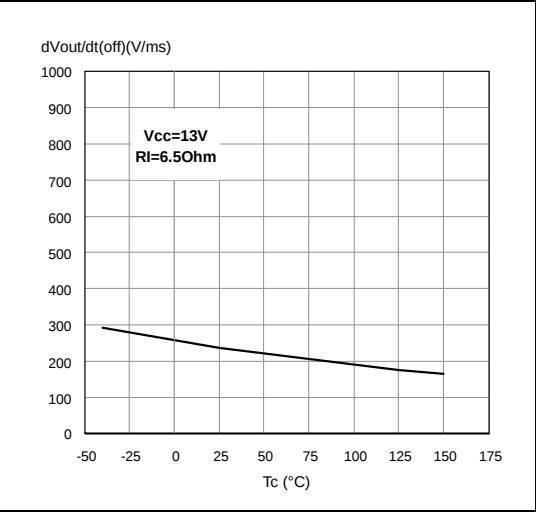


Figure 19. Status low output voltage

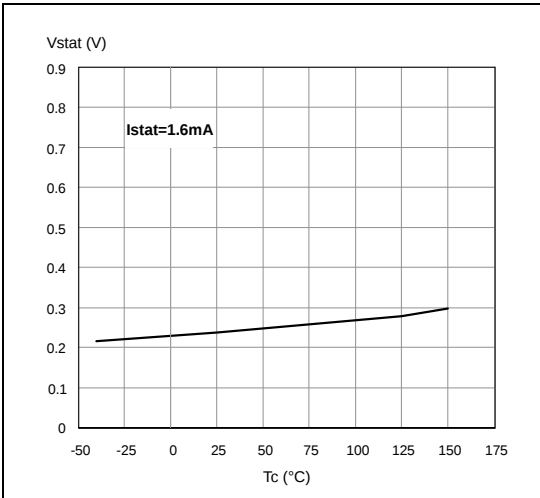


Figure 20. Status leakage current

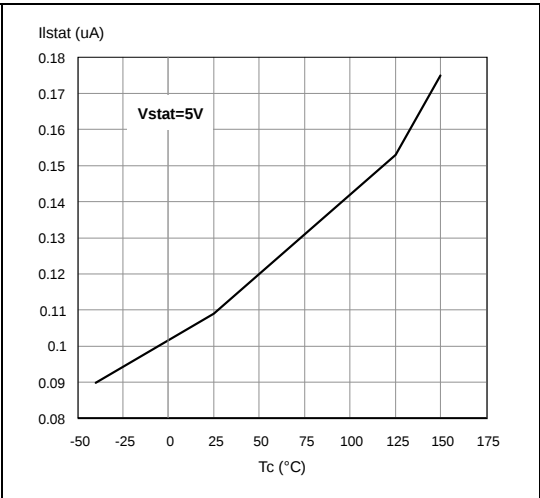


Figure 21. Status clamp voltage

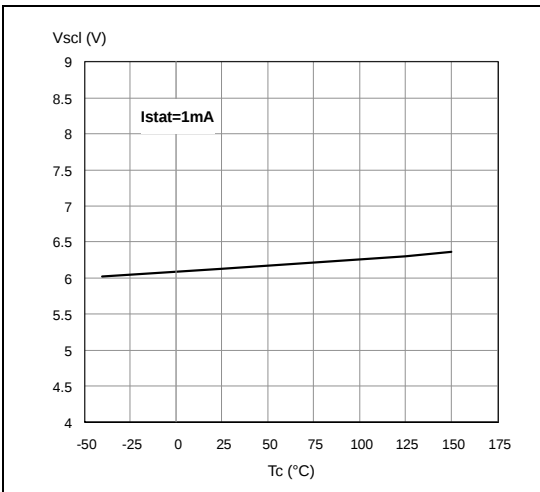


Figure 22. Open-load on-state detection threshold

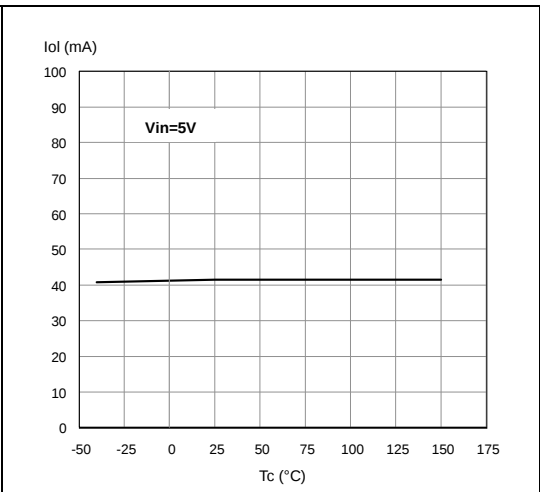


Figure 23. Open-load off-state voltage detection threshold

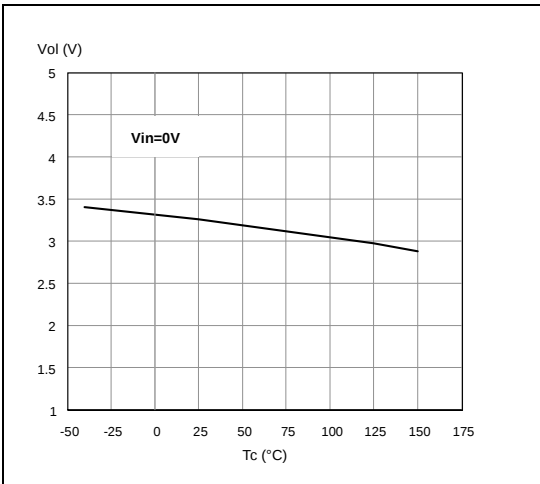


Figure 24. STAT_DIS clamp voltage

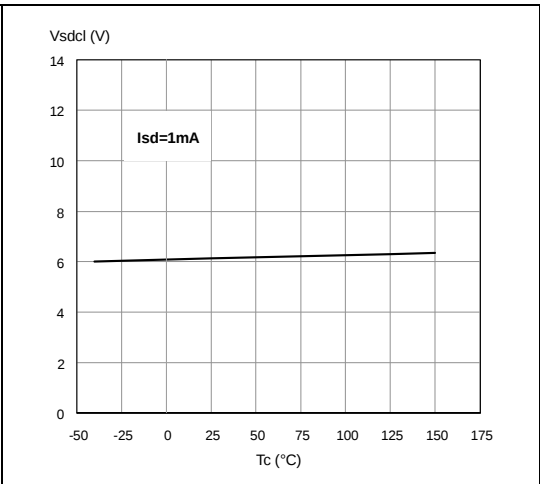
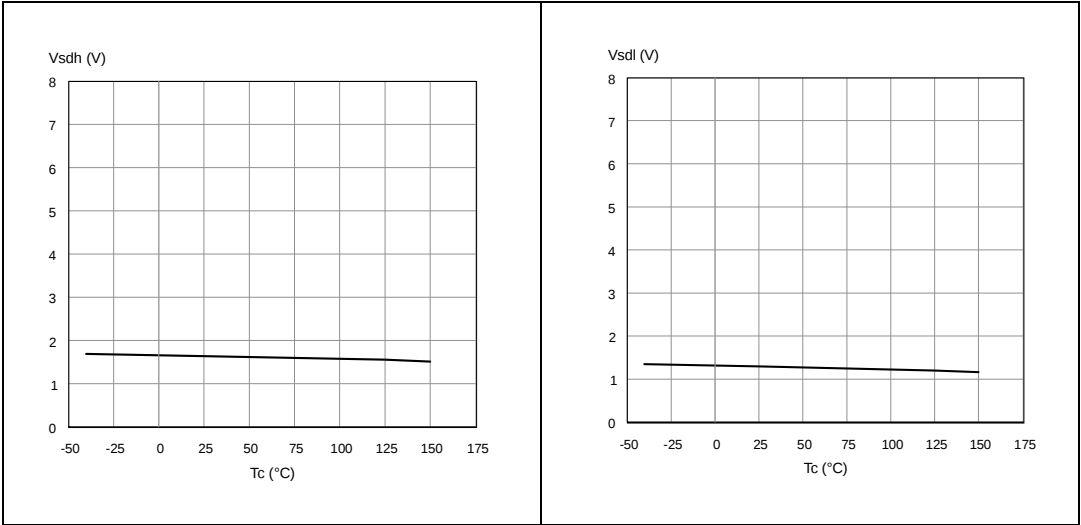
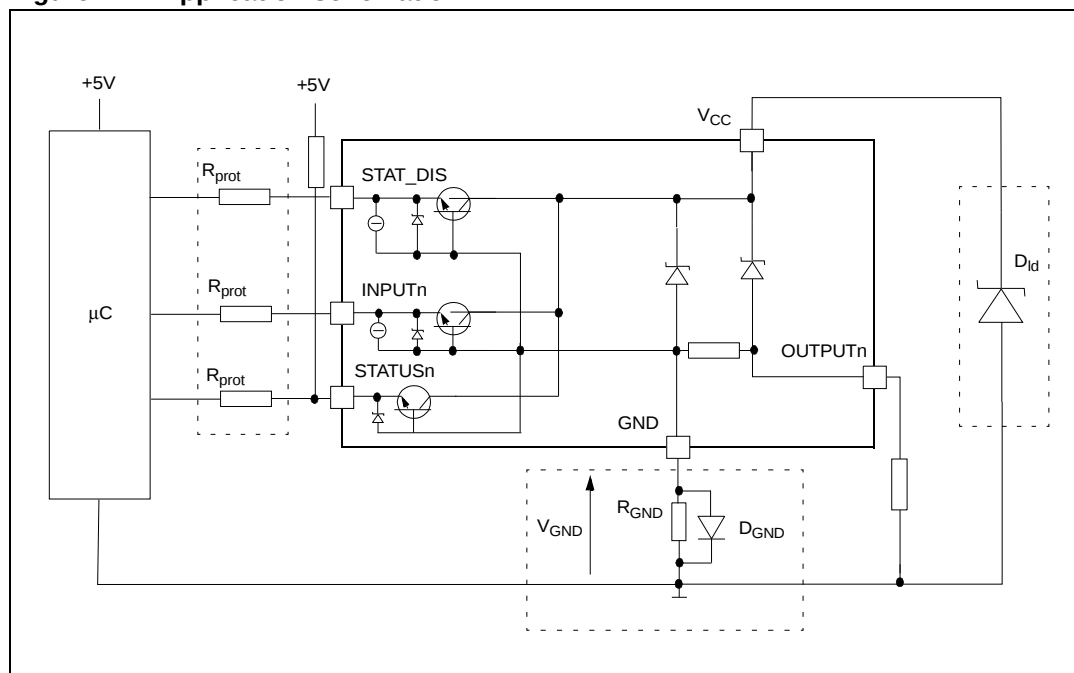


Figure 25. High level STAT_DIS voltage Figure 26. Low level STAT_DIS voltage



3 Application information

Figure 27. Application schematic



Note: Channels 2, 3 and 4 have the same internal circuit as channel 1.

3.1 GND protection network against reverse battery

3.1.1 Solution 1: resistor in the ground line (R_{GND} only)

This can be used with any type of load.

The following is an indication on how to dimension the R_{GND} resistor.

1. $R_{GND} \leq 600\text{mV} / (I_{S(on)max})$.
2. $R_{GND} \geq (-V_{CC}) / (-I_{GND})$

where $-I_{GND}$ is the DC reverse ground pin current and can be found in the absolute maximum rating section of the device datasheet.

Power Dissipation in R_{GND} (when $V_{CC} < 0$: during reverse battery situations) is:

$$P_D = (-V_{CC})^2 / R_{GND}$$

This resistor can be shared amongst several different HSDs. Please note that the value of this resistor should be calculated with formula (1) where $I_{S(on)max}$ becomes the sum of the maximum on-state currents of the different devices.

Please note that if the microprocessor ground is not shared by the device ground then the R_{GND} will produce a shift ($I_{S(on)max} * R_{GND}$) in the input thresholds and the status output values. This shift will vary depending on how many devices are ON in the case of several high side drivers sharing the same R_{GND} .

If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then ST suggests to utilize Solution 2 (see below).

3.1.2 Solution 2: a diode (D_{GND}) in the ground line

A resistor ($R_{GND}=1k\Omega$) should be inserted in parallel to D_{GND} if the device drives an inductive load.

This small signal diode can be safely shared amongst several different HSDs. Also in this case, the presence of the ground network will produce a shift ($\approx 600mV$) in the input threshold and in the status output values if the microprocessor ground is not common to the device ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

3.2 Load dump protection

D_{ld} is necessary (Voltage Transient Suppressor) if the load dump peak voltage exceeds the V_{CC} max DC rating. The same applies if the device is subject to transients on the V_{CC} line that are greater than the ones shown in the ISO T/R 7637/1 table.

3.3 Microprocessor I/Os protection

If a ground protection network is used and negative transients are present on the V_{CC} line, the control pins will be pulled negative. ST suggests to insert a resistor (R_{prot}) in line to prevent the μC I/Os pins to latch-up.

The value of these resistors is a compromise between the leakage current of μC and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of μC I/Os.

$$-V_{CCpeak}/I_{latchup} \leq R_{prot} \leq (V_{OH\mu C} - V_{IH} - V_{GND}) / I_{IHmax}$$

Calculation example:

For $V_{CCpeak} = -100V$ and $I_{latchup} \geq 20mA$; $V_{OH\mu C} \geq 4.5V$

$$5k\Omega \leq R_{prot} \leq 65k\Omega.$$

Recommended value: $R_{prot} = 10k\Omega$.

3.4 Open-load detection in off-state

Off-state open-load detection requires an external pull-up resistor (R_{PU}) connected between OUTPUT pin and a positive supply voltage (V_{PU}) like the +5V line used to supply the microprocessor.

The external resistor has to be selected according to the following requirements:

1. no false open-load indication when load is connected: in this case we have to avoid V_{OUT} to be higher than V_{OLmin} ; this results in the following condition

$$V_{OUT} = (V_{PU} / (R_L + R_{PU})) R_L < V_{OLmin}.$$
2. no misdetection when load is disconnected: in this case the V_{OUT} has to be higher than V_{OLmax} ; this results in the following condition $R_{PU} < (V_{PU} - V_{OLmax}) / I_{L(off2)}.$

Because $I_{S(OFF)}$ may significantly increase if V_{out} is pulled high (up to several mA), the pull-up resistor R_{PU} should be connected to a supply that is switched OFF when the module is in standby.

The values of V_{OLmin} , V_{OLmax} and $I_{L(off2)}$ are available in the Electrical Characteristics section.

Figure 28. Open-load detection in off-state

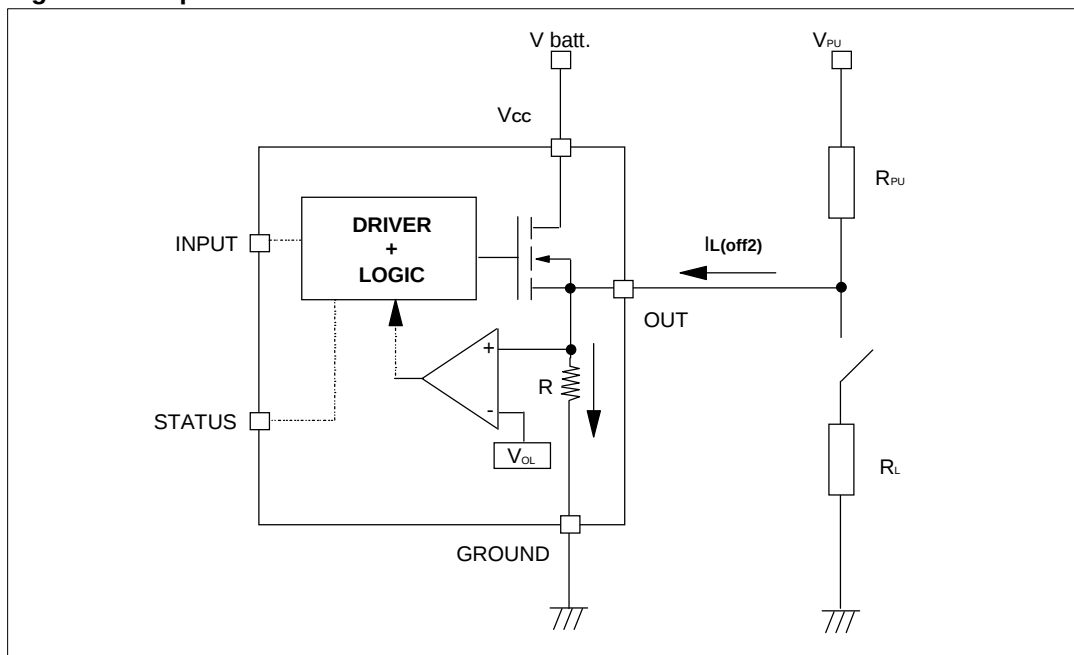
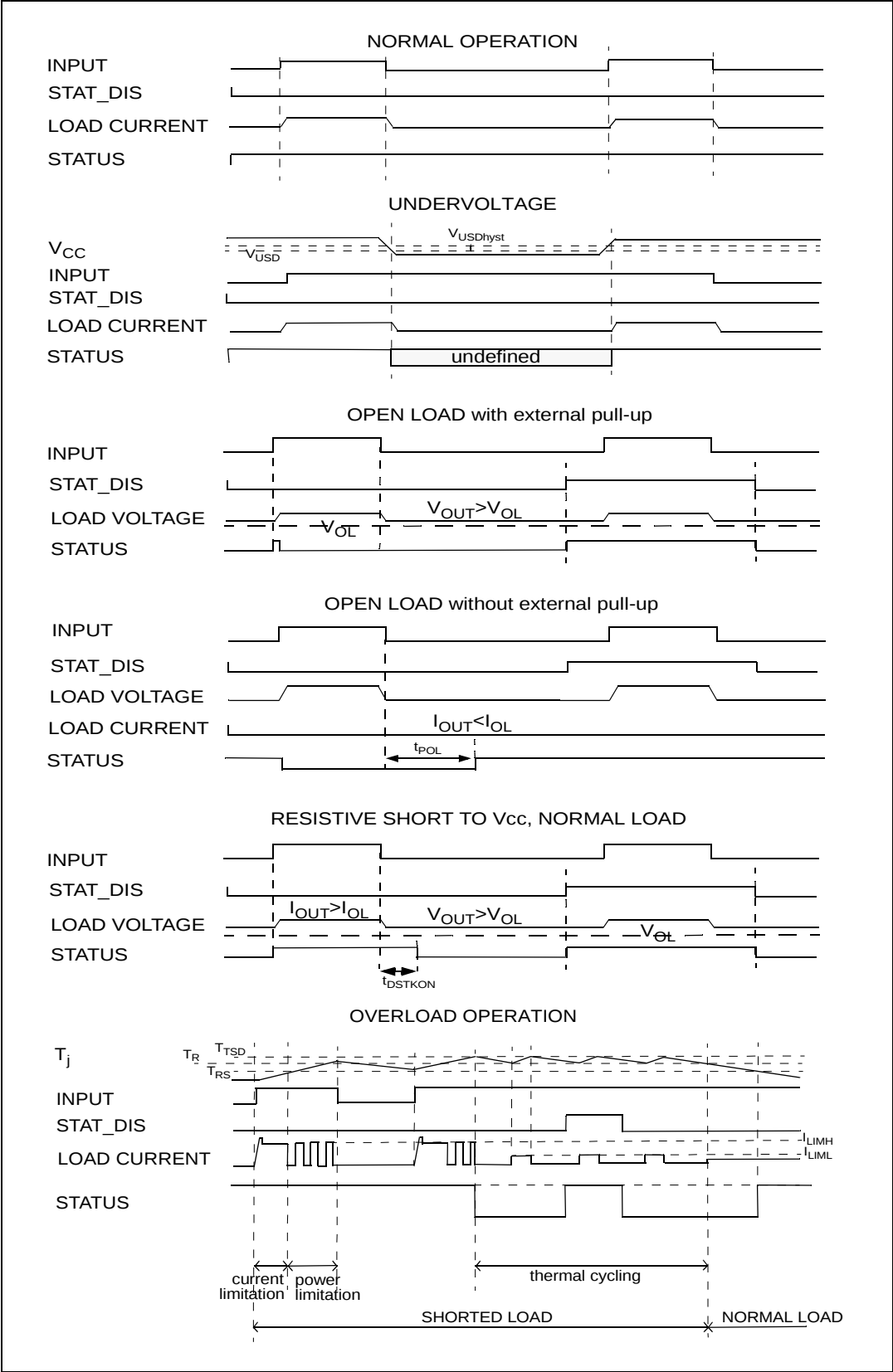
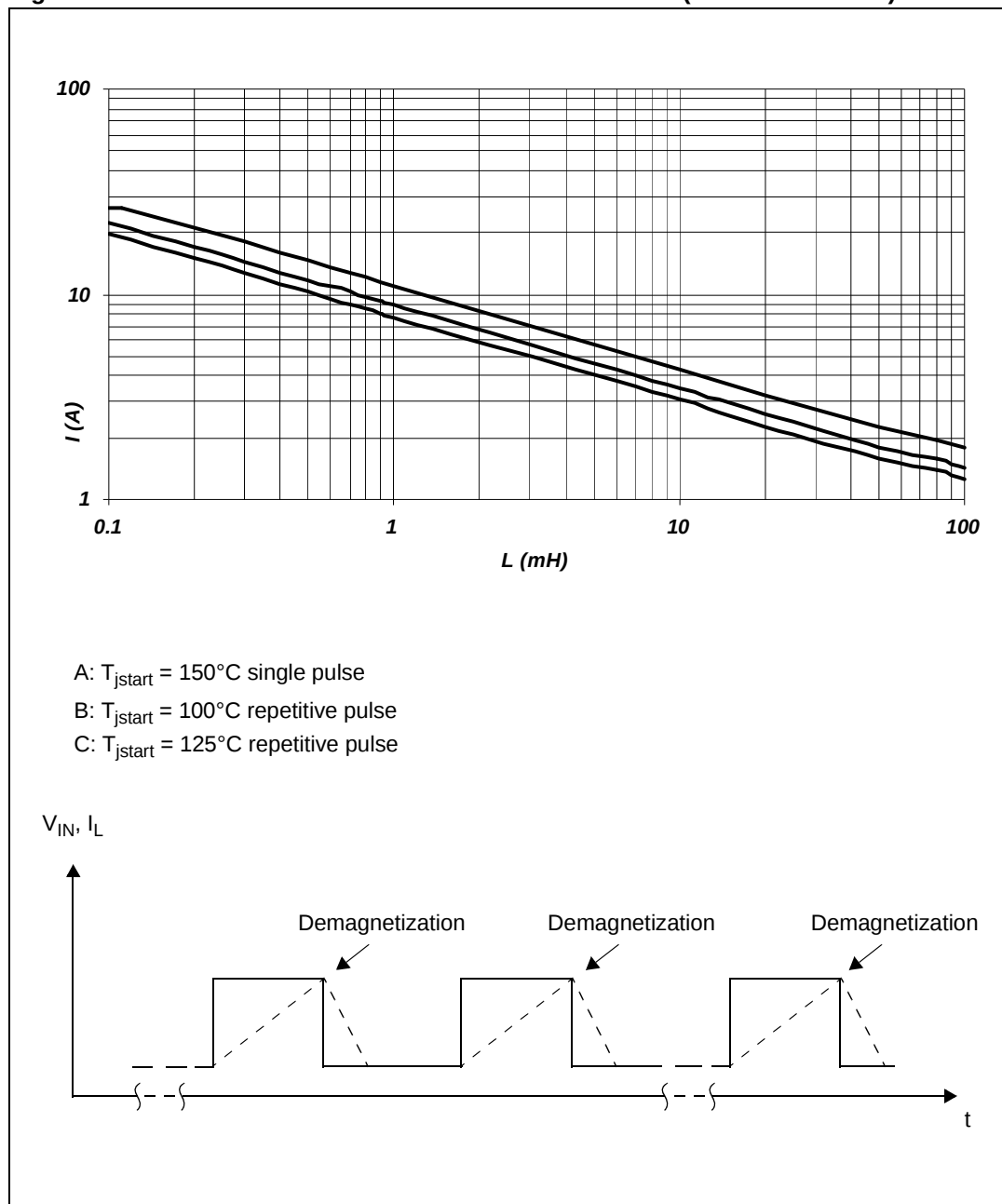


Figure 29. Waveforms



3.5 Maximum demagnetization energy ($V_{CC} = 13.5V$)

Figure 30. Maximum turn-off current versus inductance (for each channel)



Note:

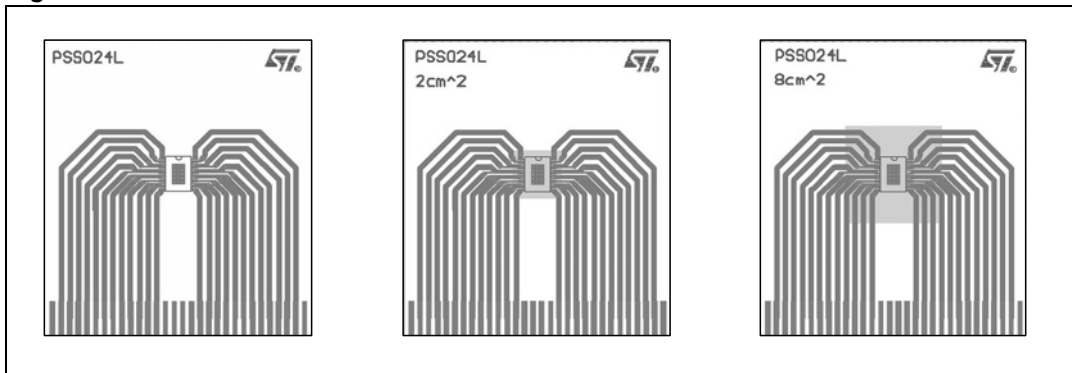
Values are generated with $R_L = 0 \Omega$

In case of repetitive pulses, T_{jstart} (at beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves A and B.

4 Package and PC board thermal data

4.1 PowerSSO-24 thermal data

Figure 31. PowerSSO-24 PC board



Note: Layout condition of R_{th} and Z_{th} measurements (PCB: Double layer, Thermal Vias, FR4 area= 77 mm x 86 mm, PCB thickness=1.6mm, Cu thickness=70 μ m (front and back side), Copper areas: from minimum pad lay-out to 8 cm²).

Figure 32. $R_{thj-amb}$ vs PCB copper area in open box free air condition (one channel on)

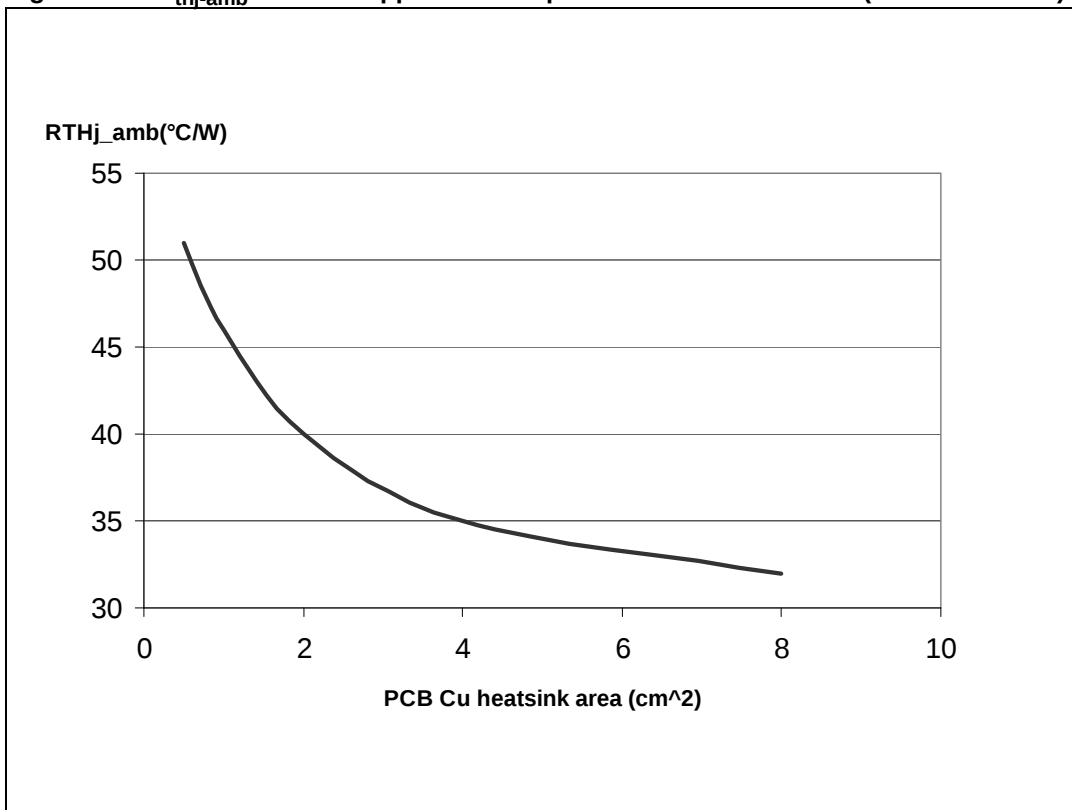
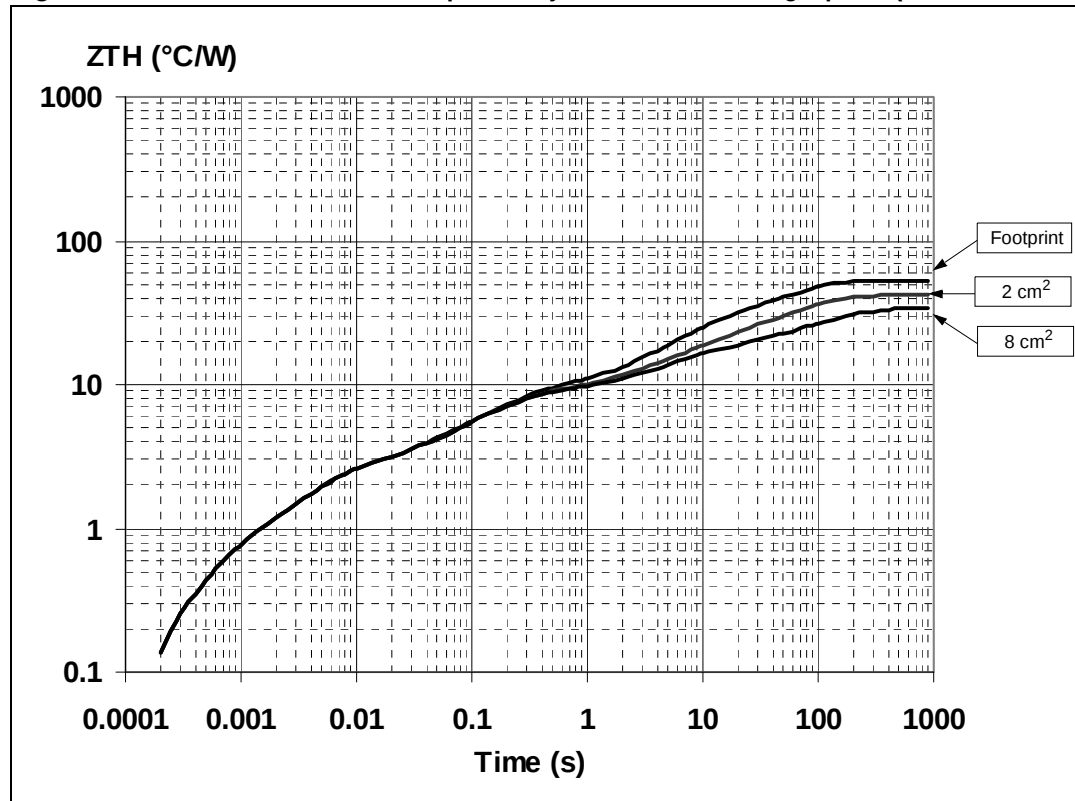
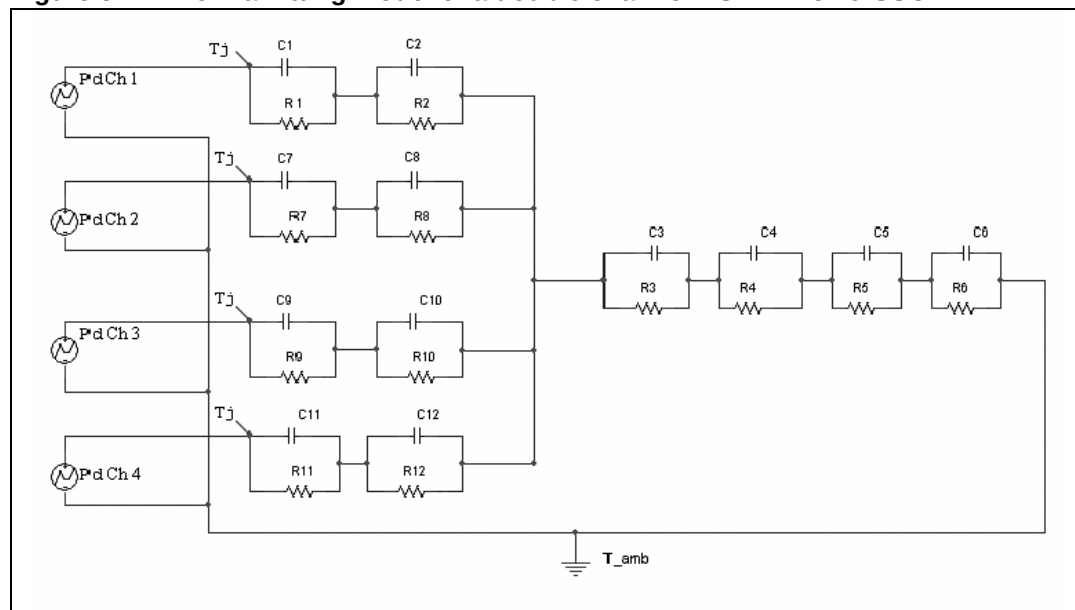


Figure 33. PowerSSO-24 thermal impedance junction ambient single pulse (one channel on)

Figure 34. Thermal fitting model of a double channel HSD in PowerSSO-24^(a)

- a. The fitting model is a simplified thermal tool and is valid for transient evolutions where the embedded protections (power limitation or thermal cycling during thermal shutdown) are not triggered

Equation 1: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

$$\text{where } \delta = t_p/T$$

Table 16. Thermal parameters

Area/island (cm ²)	Footprint	2	8
R1=R7=R9=R11 (°C/W)	0.4		
R2=R8=R10=R12 (°C/W)	2		
R3 (°C/W)	6		
R4 (°C/W)	7.7		
R5 (°C/W)	9	9	8
R6 (°C/W)	28	17	10
C1=C7=C9=C11 (W.s/°C)	0.001		
C2=C8=C10=C12 (W.s/°C)	0.0022		
C3 (W.s/°C)	0.025		
C4 (W.s/°C)	0.75		
C5 (W.s/°C)	1	4	9
C6 (W.s/°C)	2.2	5	17

5 Package and packing information

5.1 ECOPACK® packages

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.

ECOPACK® is an ST trademark.

5.2 PowerSSO-24™ mechanical data

Figure 35. PowerSSO-24™ package dimensions

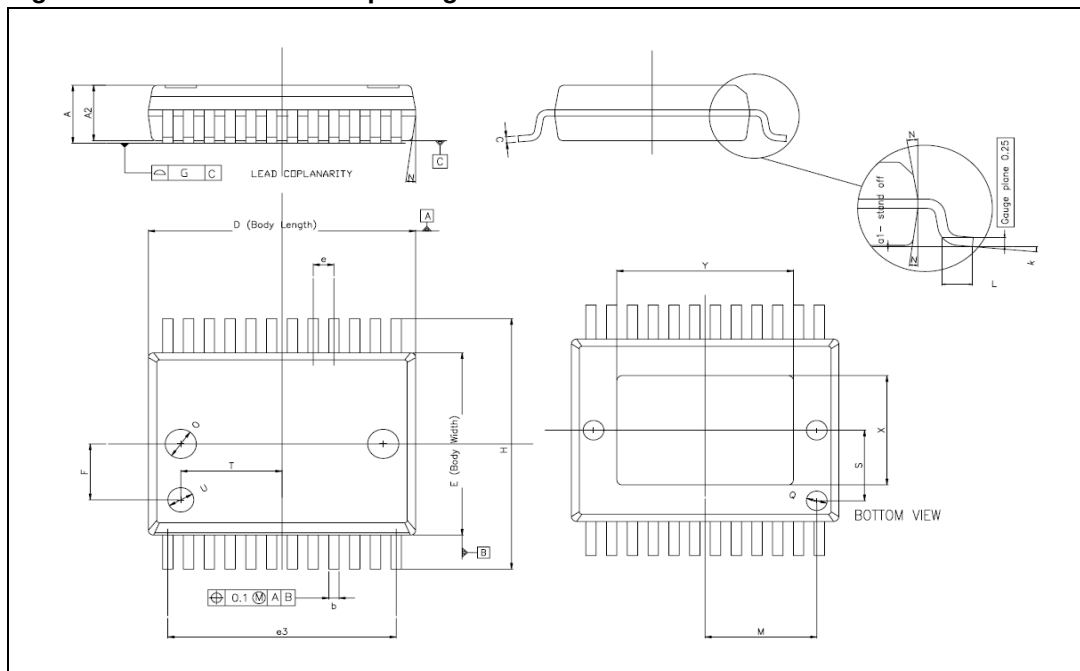


Table 17. PowerSSO-24™ mechanical data

Symbol	Millimeters		
	Min	Typ	Max
A			2.45
A2	2.15		2.35
a1	0		0.1
b	0.33		0.51
c	0.23		0.32
D	10.10		10.50
E	7.4		7.6
e		0.8	
e3		8.8	
F		2.3	
G			0.1
H	10.1		10.5
h			0.4
k	0 deg		8 deg
L	0.55		0.85
O		1.2	
Q		0.8	
S		2.9	
T		3.65	
U		1.0	
N			10 deg
X	4.1		4.7
Y	6.5		7.1

5.3 Packing information

Figure 36. PowerSSO-24 tube shipment (no suffix)

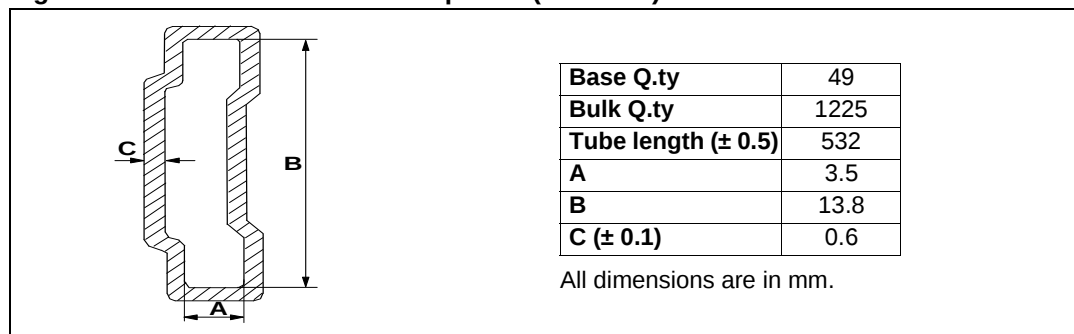
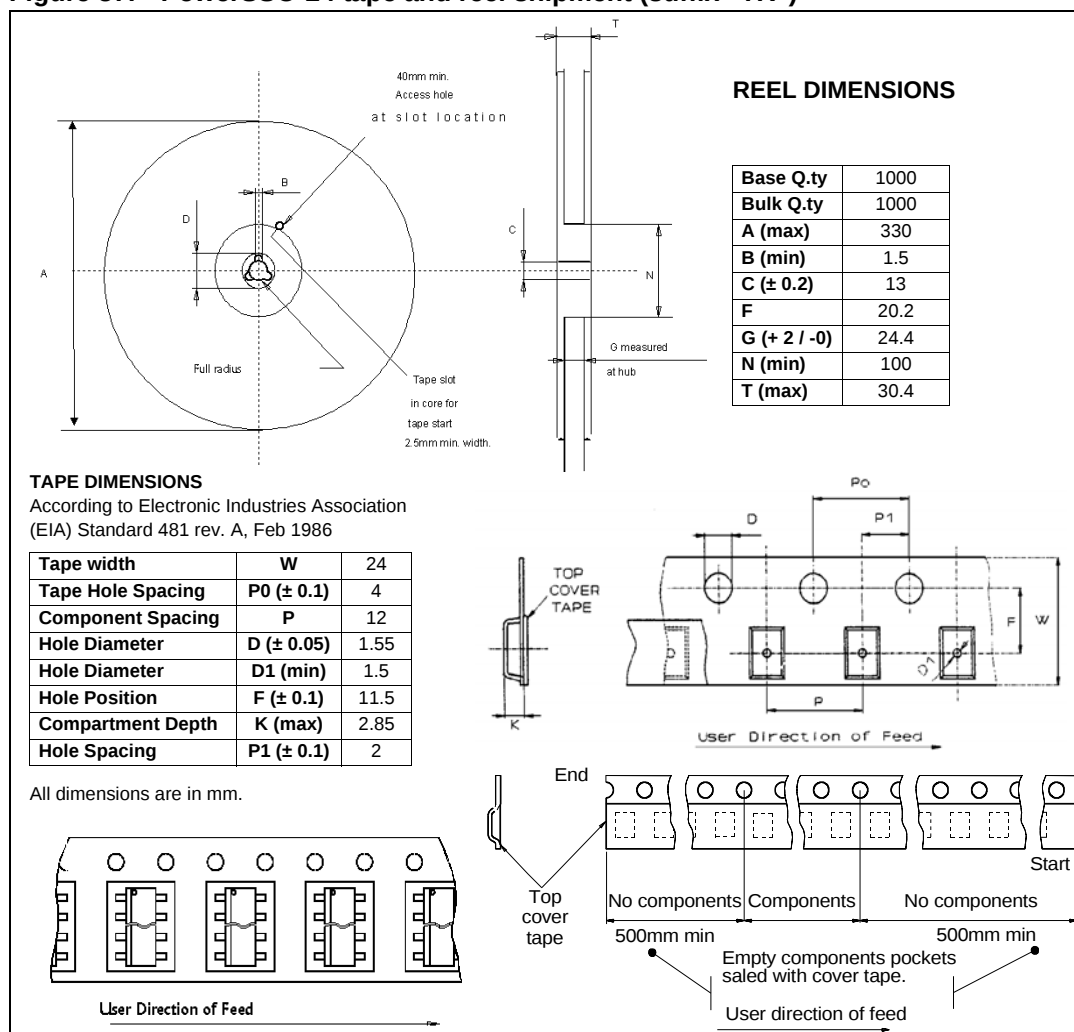


Figure 37. PowerSSO-24 tape and reel shipment (suffix "TR")



6 Revision history

Table 18. Document revision history

Date	Revision	Changes
01-Oct-2004	1	Initial release.
01-Mar-2005	2	Minor changes.
04-Jun-2007	3	Reformatted and restructured. Contents and lists of tables and figures added. Section 3.5: Maximum demagnetization energy (VCC = 13.5V) added. ECOPACK® packages information added. New disclaimer added. Table 4: Absolute maximum ratings : E _{MAX} entries updated. Table 13: Electrical transient requirements (part 1/3) : Test level values III and IV for test pulse 5b and notes updated Figure 34: Thermal fitting model of a double channel HSD in PowerSSO-24 note added
24-Jul-2007	4	Table 17: PowerSSO-24™ mechanical data updated
17-Jun-2009	5	Table 17: PowerSSO-24™ mechanical data : – Deleted A (min) value – Changed A (max) value from 2.47 to 2.45 – Changed A2 (max) value from 2.40 to 2.35 – Changed a1 (max) value from 0.075 to 0.1 – Added F row – Updated k row
22-Jun-2009	6	Updated Figure 35: PowerSSO-24™ package dimensions Updated Table 17: PowerSSO-24™ mechanical data : – Deleted G1 row – Added O, Q, S, T, and U rows
25-Sep-2013	7	Updated disclaimer.

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